

# *Notice of References Cited*

Application/Control No.

10/529,412

Applicant(s)/Patent Under  
Reexamination  
HECHT ET AL.

Examiner

Elizabeth Burkhart

Art Unit

1792

Page 1 of 1

## U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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## FOREIGN PATENT DOCUMENTS

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N	JP 11-230034	08-1999	Japan	Kawamura et al	
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## NON-PATENT DOCUMENTS

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